

# MI8605-VB Datasheet Dual P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)		
- 30	0.038 at V <sub>GS</sub> = - 10 V	- 6.4		
	0.060 at V <sub>GS</sub> = - 4.5 V	- 5		

# 3.30 mm 3.30 mm 2 3.30 mm 1 2 3.30 mm

**Bottom View** 

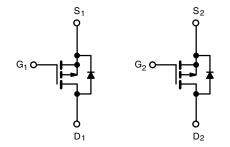
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Available
- Trench Power MOSFET
- New Low Thermal Resistance Power Package



#### **APPLICATIONS**

- Portable
  - Battery Switch
  - Load Switch



P-Channel MOSFET

P-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b>	T <sub>A</sub> = 25 °C, unles	s otherwise n	oted		
Parameter		Symbol	10 s	Steady State	Unit
Drain-Source Voltage		V <sub>DS</sub>	- 30		V
Gate-Source Voltage		V <sub>GS</sub>	± 20		
Continuous Dunin Courset /T 450 90\d	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 6.4	- 4.3	
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>A</sub> = 85 °C		- 4.6	- 3.1	Δ.
Pulsed Drain Current		I <sub>DM</sub>	- 20		Α
Continuous Source Current (Diode Conduction) <sup>a</sup>	I <sub>S</sub>	- 2.3	- 1.1		
Mariana Dana Diada da diada	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.8	1.3	W
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 85 °C	' D	1.5	0.85	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		°C
Soldering Recommendations (Peak Temperature) <sup>b, c</sup>			260		٠.

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Marrian una lungation de Ambriando	t ≤ 10 s	R <sub>thJA</sub>	35	44	°C/W	
Maximum Junction-to-Ambient <sup>a</sup>	Steady State	' 'thJA	75	94		
Maximum Junction-to-Case (Drain)	Steady State	$R_{thJC}$	4	5		

#### Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. The DFN3x3 package is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- c. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.



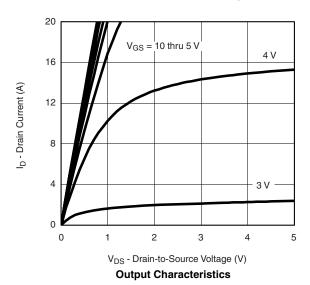
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	- 1.0		- 3.0	٧	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V		- 1			
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 5	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 20			Α	
D : 0	В	V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 6.4 A		0.038		Ω	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 5 A		0.060			
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 6.4 A		13		S	
Diode Forward Voltage <sup>a</sup>	$V_{SD}$	I <sub>S</sub> = - 2.3 A, V <sub>GS</sub> = 0 V		- 0.8	- 1.2	٧	
Dynamic <sup>b</sup>			•	•			
Total Gate Charge	$Q_g$			14	21		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -15 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -6.4 \text{ A}$		2.4		nC	
Gate-Drain Charge	$Q_{gd}$			3.8		1	
Gate Resistance	$R_g$			8.5		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			10	15		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 15 $\Omega$		12	20		
Turn-Off Delay Time	t <sub>d(off)</sub>	$\text{I}_\text{D}\cong\text{1 A, V}_\text{GEN}=\text{10 V, R}_g=\text{6}~\Omega$		38	60	ns	
Fall Time	t <sub>f</sub>			28	45		
Source-Drain Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = - 2.3 A, dl/dt = 100 A/μs		20	40		

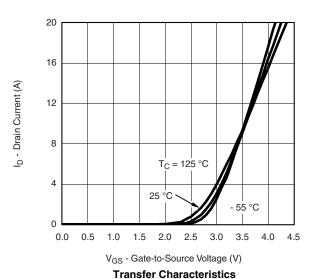
#### Notes:

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

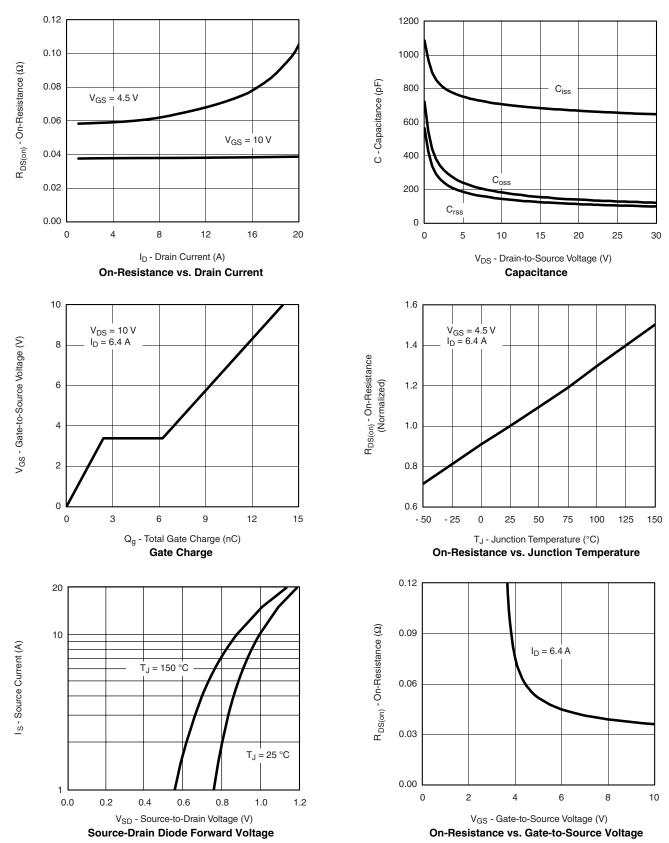
#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





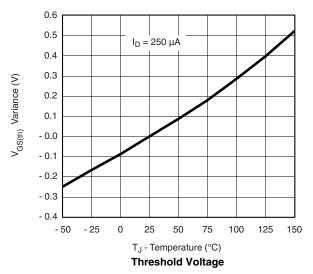


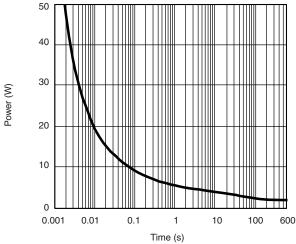
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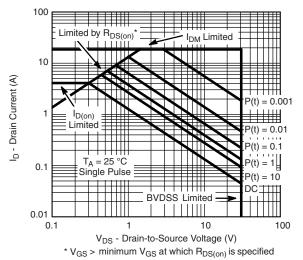


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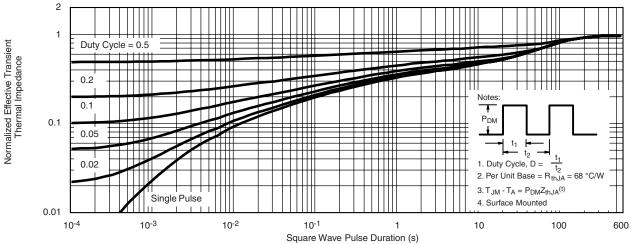




Single Pulse Power, Junction-to-Ambient



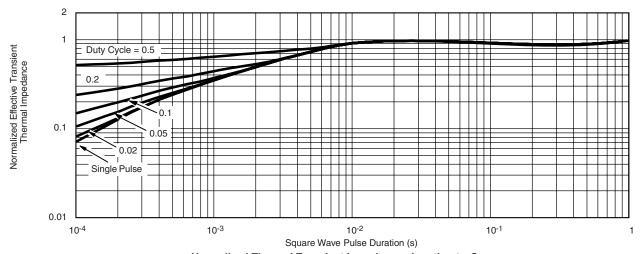




Normalized Thermal Transient Impedance, Junction-to-Ambient



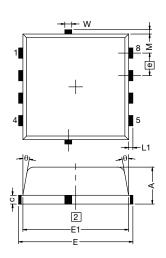
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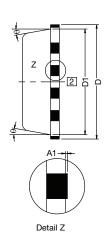


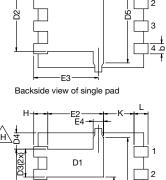
Normalized Thermal Transient Impedance, Junction-to-Case



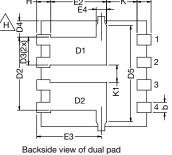
# DFN3x3, (Single / Dual)







Notes
1. Inch will govern
2 Dimensions exclusive of mold gate burrs
3. Dimensions exclusive of mold flash and cutting burrs



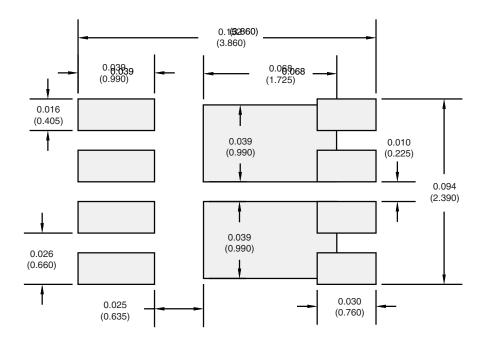
DIM		MILLIMETERS			INCHES			
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.		
Α	0.97	1.04	1.12	0.038	0.041	0.044		
A1	0.00	-	0.05	0.000	-	0.002		
b	0.23	0.30	0.41	0.009	0.012	0.016		
С	0.23	0.28	0.33	0.009	0.011	0.013		
D	3.20	3.30	3.40	0.126	0.130	0.134		
D1	2.95	3.05	3.15	0.116	0.120	0.124		
D2	1.98	2.11	2.24	0.078	0.083	0.088		
D3	0.48	-	0.89	0.019	-	0.035		
D4		0.47 typ.			0.0185 typ			
D5		2.3 typ.			0.090 typ			
Е	3.20	3.30	3.40	0.126	0.130	0.134		
E1	2.95	3.05	3.15	0.116	0.120	0.124		
E2	1.47	1.60	1.73	0.058	0.063	0.068		
E3	1.75	1.85	1.98	0.069	0.073	0.078		
E4		0.034 typ.			0.013 typ.			
е	0.65 BSC		0.026 BSC					
K	0.86 typ.		0.034 typ.					
K1	0.35	-	-	0.014	=	-		
Н	0.30	0.41	0.51	0.012	0.016	0.020		
L	0.30	0.43	0.56	0.012	0.017	0.022		
L1	0.06	0.13	0.20	0.002	0.005	0.008		
θ	0°	-	12°	0°	-	12°		
W	0.15	0.25	0.36	0.006	0.010	0.014		
М		0.125 typ.	o. 0.005 typ.					
ECN: S16-2667-Rev. M, 09-Jan-17								

DWG: 5882



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#### **RECOMMENDED MINIMUM PADS FOR DFN 3x3 Dual**



Recommended Minimum PADs for PowerPAK 1212-8 Dual Dimensions in Inches/(mm)



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